

RoHS Compliant Product

A suffix of "-C" specifies halogen & lead-free

DESCRIPTION

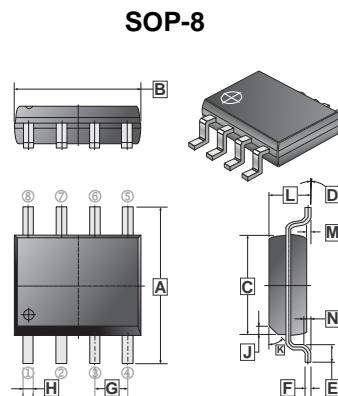
These miniature surface mount MOSFETs utilize a high cell density trench process to provide low $R_{DS(on)}$ and to ensure minimal power loss and heat dissipation. Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

FEATURES

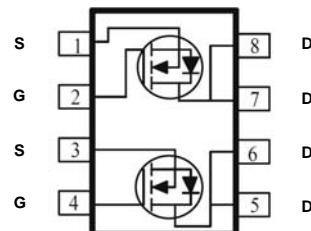
- Low $R_{DS(on)}$ provides higher efficiency and extends battery life.
- Low thermal impedance copper leadframe SOP-8 saves board space.
- Fast switching speed.
- High performance trench technology.

PACKAGE INFORMATION

Package	MPQ	Leader Size
SOP-8	2.5K	13' inch



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	5.80	6.20	H	0.35	0.49
B	4.80	5.00	J	0.375	REF.
C	3.80	4.00	K	45°	
D	0°	8°	L	1.35	1.75
E	0.40	0.90	M	0.10	0.25
F	0.19	0.25	N	0.25 REF.	
G	1.27 TYP.				



MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Ratings		Unit
Drain-Source Voltage	V_{DS}	150		V
Gate-Source Voltage	V_{GS}	± 20		V
Continuous Drain Current ¹	I_D	1.4		A
		1.1		
Pulsed Drain Current ²	I_{DM}	10		A
Continuous Source Current (Diode Conduction) ¹	I_S	2.6		A
Power Dissipation ¹	P_D	2.1		W
		1.3		
Operating Junction & Storage Temperature Range	T_J, T_{STG}	-55 ~ 150		°C
THERMAL RESISTANCE RATINGS				
Maximum Junction to Ambient ¹	$t \leq 10 \text{ sec}$	$R_{\theta JA}$	62.5	°C / W
			110	°C / W

Notes

1 Surface Mounted on 1" x 1" FR4 Board.

2 Pulse width limited by maximum junction temperature.

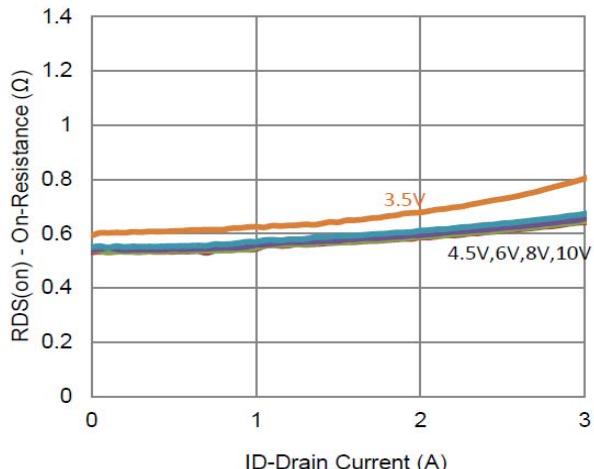
ELECTRICAL CHARACTERISTICS ($T_A=25^\circ C$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test conditions
Static						
Gate-Threshold Voltage	$V_{GS(th)}$	1	-	-	V	$V_{DS}=V_{GS}$, $I_D=250\mu A$
Gate-Body Leakage	I_{GSS}	-	-	± 100	nA	$V_{DS}=0$, $V_{GS}=20V$
Zero Gate Voltage Drain Current	I_{DSS}	-	-	1	μA	$V_{DS}=120V$, $V_{GS}=0$
		-	-	10		$V_{DS}=120V$, $V_{GS}=0$, $T_J=55^\circ C$
On-State Drain Current	$I_{D(on)}$	0.5	-	-	A	$V_{DS}=5V$, $V_{GS}=10V$
Drain-Source On-Resistance	$R_{DS(ON)}$	-	-	0.7	Ω	$V_{GS}=10V$, $I_D=1.2A$
		-	-	1.2		$V_{GS}=4.5V$, $I_D=1.1A$
Forward Transconductance	g_{fs}	-	11	-	S	$V_{DS}=15V$, $I_D=1.2A$
Diode Forward Voltage	V_{SD}	-	0.8	-	V	$I_S=1.3A$, $V_{GS}=0$
Dynamic²						
Input Capacitance	C_{iss}	-	347	-	pF	$V_{DS}=15V$, $V_{GS}=0$, $f=1MHz$
Output Capacitance	C_{oss}	-	37	-		
Reverse Transfer Capacitance	C_{rss}	-	20	-		
Total Gate Charge	Q_g	-	3.7	-	nC	$I_D= 1.2A$ $V_{DS}= 75V$ $V_{GS}= 4.5V$
Gate-Source Charge	Q_{gs}	-	1.3	-		
Gate-Drain Charge	Q_{gd}	-	1.8	-		
Turn-On Delay Time	$T_{d(on)}$	-	5	-	nS	$V_{DD}=75V$ $I_D=1.2A$ $V_{GEN}=10V$ $R_L=62.5\Omega$ $R_{GEN}=6\Omega$
Rise Time	T_r	-	10	-		
Turn-Off Delay Time	$T_{d(off)}$	-	16	-		
Fall Time	T_f	-	8	-		

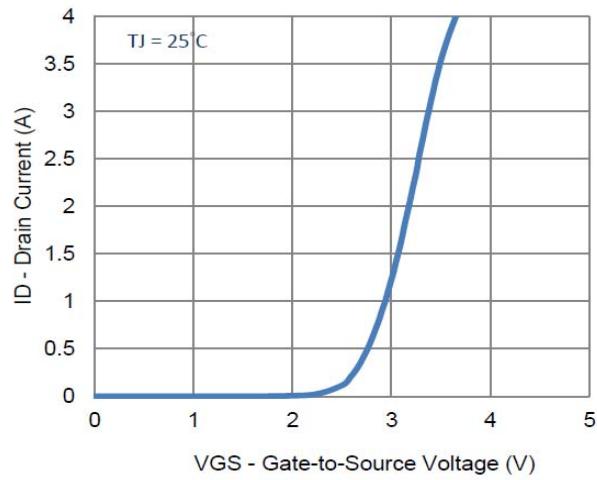
Notes

- 1 Pulse test : PW \leq 300μs duty cycle \leq 2%.
- 2 Guaranteed by design, not subject to production testing.

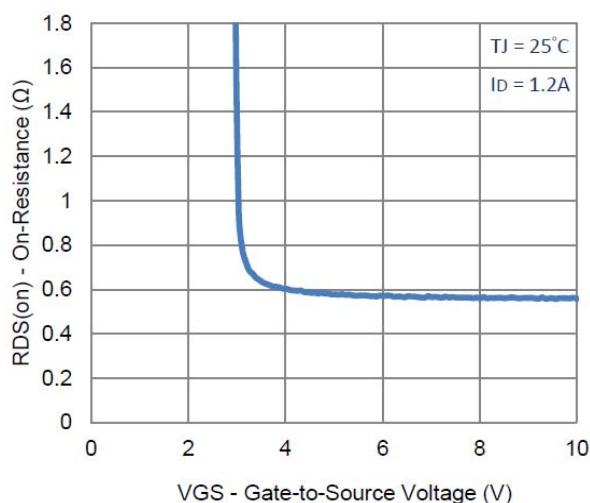
CHARACTERISTICS CURVE



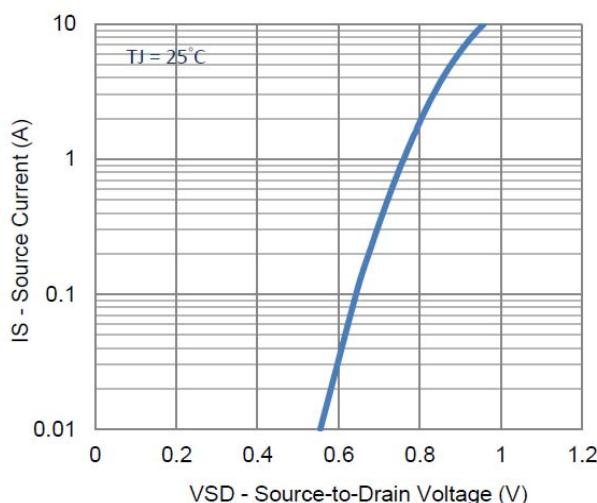
1. On-Resistance vs. Drain Current



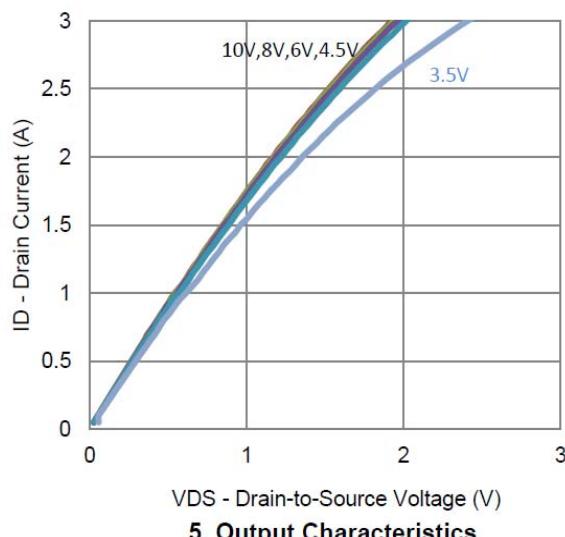
2. Transfer Characteristics



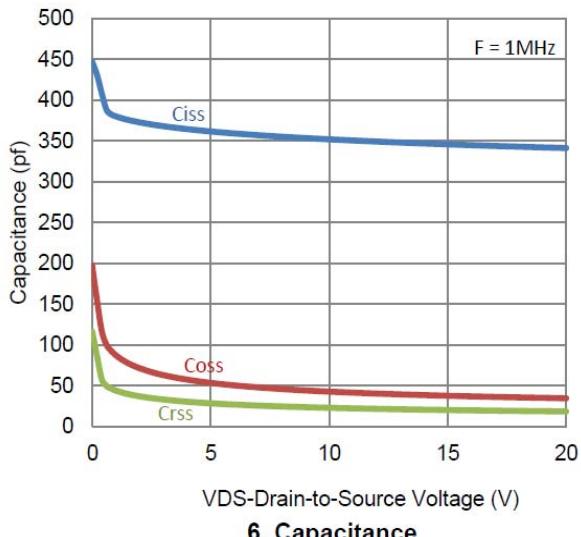
3. On-Resistance vs. Gate-to-Source Voltage



4. Drain-to-Source Forward Voltage



5. Output Characteristics



Any changes of specification will not be informed individually.

CHARACTERISTICS CURVE

